R&S®RTE
Digital Oscilloscope
Specifications

Test & Measurement

Data Sheet | 05.00

ROHDE&SCHWARZ

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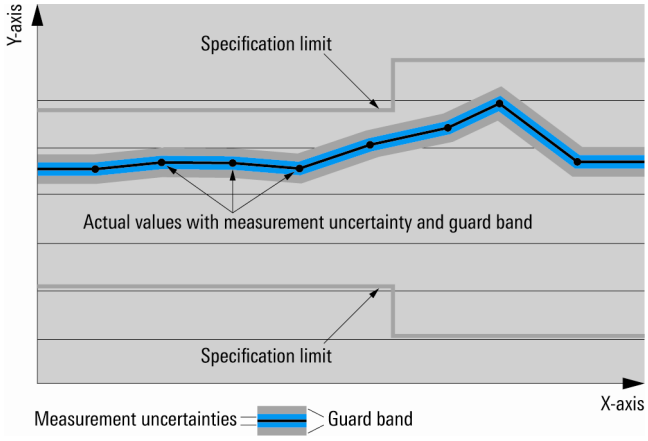
Definitions

General
Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- Recommended calibration interval adhered to
- All internal automatic adjustments performed, if applicable

Specifications with limits
Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, ≤, >, ≥, ±, or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Specifications without limits
Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)
Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)
Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)
Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties
Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are indicated as follows: “parameter: value”.

Typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

Base unit

Vertical system

Input channels	R&S®RTE1022	2 channels
	R&S®RTE1024	4 channels
	R&S®RTE1032	2 channels
	R&S®RTE1034	4 channels
	R&S®RTE1052	2 channels
	R&S®RTE1054	4 channels
	R&S®RTE1102	2 channels
	R&S®RTE1104	4 channels
Input impedance		50 Ω ± 1.5 % 1 MΩ ± 1 % || 16 pF ± 1 pF (meas.)
Analog bandwidth (–3 dB)	at 50 Ω input impedance	
	R&S®RTE1022 and R&S®RTE1024	≥ 200 MHz
	R&S®RTE1032 and R&S®RTE1034	≥ 350 MHz
	R&S®RTE1052 and R&S®RTE1054	≥ 500 MHz
	R&S®RTE1102 and R&S®RTE1104	≥ 1 GHz
	at 1 MΩ input impedance	
	R&S®RTE1022 and R&S®RTE1024	≥ 200 MHz (meas.)
	R&S®RTE1032 and R&S®RTE1034	≥ 350 MHz (meas.)
	R&S®RTE1052, R&S®RTE1054, R&S®RTE1102 and R&S®RTE1104	≥ 500 MHz (meas.)
Analog bandwidth limits	max. –1.5 dB, min. –4 dB	200 MHz, 20 MHz
Rise time/fall time	10 % to 90 % at 50 Ω (calculated)	
	R&S®RTE1022 and R&S®RTE1024	< 1.75 ns
	R&S®RTE1032 and R&S®RTE1034	< 1 ns
	R&S®RTE1052 and R&S®RTE1054	< 700 ps
	R&S®RTE1102 and R&S®RTE1104	< 350 ps
Input VSWR	input frequency ≤ 500 MHz	1.25 (meas.)
	input frequency > 500 MHz	1.4 (meas.)
Vertical resolution		8 bit, 16 bit for high resolution decimation (with reduction of the sampling rate), 16 bit for high definition mode (without reduction of the sampling rate, requires the option R&S®RTE-K17)
Effective number of bits of digitizer	for full-scale sine-wave signal with frequency equal to or lower than –3 dB bandwidth	> 7.0 bit (meas.)
DC gain accuracy	offset and position set to 0 V, after self-alignment	
	input sensitivity > 5 mV/div	±1.5 %
	input sensitivity ≤ 5 mV/div	±2 %
Input coupling	at 50 Ω	DC and GND
	at 1 MΩ	DC, AC and GND
Input sensitivity	at 50 Ω	1 mV/div to 1 V/div
	at 1 MΩ	1 mV/div to 10 V/div
Maximum input voltage	at 50 Ω	5 V (RMS), max. 30 V (V_p)
	at 1 MΩ	150 V (RMS), 200 V (V_p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz
Position range		±5 div

Offset range at 50 Ω	input sensitivity	
	100 mV/div to 1 V/div	±5 V
	1 mV/div to < 100 mV/div	±1 V
Offset range at 1 MΩ	input sensitivity	
	800 mV/div to 10 V/div	±(100 V – input sensitivity × 5 div)
	80 mV/div to < 800 mV/div	±(10 V – input sensitivity × 5 div)
	1 mV/div to < 80 mV/div	±(1 V – input sensitivity × 5 div)
Offset accuracy		±(0.5 % × |net offset| + 1 mV + 0.15 div × input sensitivity) (net offset = offset – position × input sensitivity)
DC measurement accuracy	after adequate suppression of measurement noise using high-resolution sampling mode or waveform averaging or a combination of both	±(DC gain accuracy × |reading – net offset| + offset accuracy)
Channel-to-channel isolation (each channel at same input sensitivity)	input frequency ≤ 500 MHz	> 50 dB
	input frequency > 500 MHz	> 40 dB

Horizontal system

Timebase range		selectable between 50 ps/div and 50 s/div, time per div settable to any value within range
Channel deskew		±100 ns
Reference position		0 % to 100 % of measurement display area
Trigger offset range	max.	+(memory depth/current sampling rate)
	min.	–10 000 s
Modes		normal, roll
Channel-to-channel skew		< 200 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±5 ppm
	during calibration interval	±10 ppm
Delta time accuracy	corresponds to time error between two edges on same acquisition and channel; signal amplitude greater than 5 divisions, measurement threshold set to 50 %, vertical gain 10 mV/div or greater; rise time lower than four sample periods; waveform acquired in realtime mode	±(K/realtime sampling rate + timebase accuracy × |reading|) (peak) (meas.) where K = 0.15 (R&S®RTE1022, R&S®RTE1024) K = 0.18 (R&S®RTE1032, R&S®RTE1034) K = 0.25 (R&S®RTE1052, R&S®RTE1054) K = 0.43 (R&S®RTE1102, R&S®RTE1104)

Acquisition system

Realtime sampling rate		max. 5 Gsample/s on each channel
Realtime waveform acquisition rate	max.	> 1 000 000 waveforms/s
Memory depth	standard	
	R&S®RTE1022, R&S®RTE1032, R&S®RTE1052, R&S®RTE1102	10 Msample on 2 channels, 20 Msample on 1 channel
	R&S®RTE1024, R&S®RTE1034, R&S®RTE1054, R&S®RTE1104	10 Msample on 4 channels, 20 Msample on 2 channels, 40 Msample on 1 channel
	R&S®RTE-B101 option	
	R&S®RTE1022, R&S®RTE1032, R&S®RTE1052, R&S®RTE1102	20 Msample on 2 channels, 40 Msample on 1 channel
	R&S®RTE1024, R&S®RTE1034, R&S®RTE1054, R&S®RTE1104	20 Msample on 4 channels, 40 Msample on 2 channels, 80 Msample on 1 channel
	R&S®RTE-B102 option	
	R&S®RTE1022, R&S®RTE1032, R&S®RTE1052, R&S®RTE1102	50 Msample on 2 channels, 100 Msample on 1 channel
	R&S®RTE1024, R&S®RTE1034, R&S®RTE1054, R&S®RTE1104	50 Msample on 4 channels, 100 Msample on 2 channels, 200 Msample on 1 channel
Decimation modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval
	high resolution	average value of samples in decimation interval
	root mean square	root of squared average of samples in decimation interval
Waveform arithmetic	off	no arithmetic
	envelope	envelope of acquired waveforms
	average	average of acquired waveforms, max. average depth depends on decimation mode [1]
	sample	max. 16 777 215
	high resolution	max. 65 535
	root mean square	max. 255
	reset condition	no reset (standard), manual reset
Waveform streams per channel		1 with selection of decimation mode and waveform arithmetic independently for each channel
Sampling modes	realtime mode	max. sampling rate set by digitizer
	interpolated time	enhancement of sampling resolution by interpolation; max. equivalent sampling rate is 2 Tsample/s
Interpolation modes		linear, sin(x)/x, sample&hold
Ultra segmented mode		continuous recording of waveforms in acquisition memory without interruption due to visualization; blind time between consecutive acquisitions less than 400 ns

[1] Waveform averaging is not compatible with peak detect decimation.

Trigger system

Sources	R&S®RTE1022, R&S®RTE1032, R&S®RTE1052, R&S®RTE1102	channel 1, channel 2
	R&S®RTE1024, R&S®RTE1034, R&S®RTE1054, R&S®RTE1104	channel 1, channel 2, channel 3, channel 4
Sensitivity	trigger hysteresis mode	auto (standard) or manual
	range	0 V to 5 div × input sensitivity
Trigger jitter	full-scale sine wave of frequency set to –3 dB bandwidth	< 1 ps (RMS) (meas.)
Coupling mode	standard	same as selected channel
	lowpass filter	cutoff frequency selectable from 50 kHz to 50 % of analog bandwidth
Sweep mode		auto, normal, single, n single
Event rate	max.	one event for every 800 ps time interval
Trigger level	range	±5 div from center of screen
Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

Main trigger modes		
Edge	triggers on specified slope (positive, negative or either) and level	
Glitch	triggers on glitches of positive, negative or either polarity that are shorter or longer than specified width	
	glitch width	200 ps to 1000 s
Width	triggers on positive or negative pulse of specified width; width can be shorter, longer, inside or outside the interval	
	pulse width	200 ps to 1000 s
Runt	triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again; runt pulse width can be arbitrary, shorter, longer, inside or outside the interval	
	runt pulse width	200 ps to 1000 s
Window	triggers when signal enters or exits a specified voltage range; triggers also when signal stays inside or outside the voltage range for a specified period of time	
Timeout	triggers when signal stays high, low or unchanged for a specified period of time	
	timeout	200 ps to 1000 s
Interval	triggers when time between two consecutive edges of same slope (positive or negative) is shorter, longer, inside or outside a specified range	
	interval time	200 ps to 1000 s
Slew rate	triggers when the time required by a signal edge to toggle between user-defined upper and lower voltage levels is shorter, longer, inside or outside the interval; edge slope may be positive, negative or either	
	toggle time	200 ps to 1000 s
Data2clock	triggers on setup time and hold time violations between clock and data present on any two input channels; monitored time interval may be specified by the user in the range from –100 ns to 100 ns around a clock edge and must be at least 200 ps wide	
Pattern	triggers when a logical combination (AND, NAND, OR, NOR) of the input channels stays true for a period of time shorter, longer, inside or outside a specified range	
State	triggers when a logical combination (AND, NAND, OR, NOR) of the input channels stays true at a slope (positive, negative or either) in one selected channel	
Serial pattern	triggers on serial data pattern up to 128 bit clocked by one input channel; pattern bits may be high (H), low (L) or don't care (X); clock edge slope may be positive, negative or either	
	max. data rate	< 1.25 Gbps
TV/video	triggers on baseband analog progressive and interlaced video signals including NTSC, PAL, PAL-M, SECAM, EDTV and HDTV broadcast standards as well as custom bi-level and tri-level sync video standards	
	trigger modes	all fields, odd fields, even fields, all lines, line number
Line	triggers with the frequency of the AC power line voltage	

Advanced trigger modes		
Sequence trigger (A/B trigger)	triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events	
	A event	any trigger mode
	B event	edge
Serial bus trigger	optional	I^2C, SPI, UART/RS-232, LIN, CAN, FlexRay™ and I^2S with dedicated software options
External trigger input	input impedance	50 Ω ± 1.5 % (meas.), 1 MΩ ± 1 % || 14 pF (meas.)
	max. input voltage at 50 Ω	5 V (RMS)
	max. input voltage at 1 MΩ	30 V (RMS) derates at 20 dB/decade to 5 V (RMS) above 5 MHz
	trigger level range	±5 V
	sensitivity, for input frequency ≤ 500 MHz	300 mV (V_{pp})
	input coupling	AC, DC (50 Ω and 1 MΩ), GND, HF reject (attenuates > 50 kHz), LF reject (attenuates < 50 kHz)
	trigger modes	edge (rise or fall)
Trigger out	functionality	a pulse is generated for every acquisition trigger event
	output voltage	0 V to 5 V at high impedance; 0 V to 2.5 V at 50 Ω
	pulse width	selectable between 50 ns and 60 ms
	pulse polarity	low active or high active
	output delay	depends on trigger settings
	jitter	±600 ps (meas.)

Waveform measurements

General features	measurements	up to 8 measurements
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic measurements
	statistics	displays maximum, minimum, mean, standard deviation, RMS and measurement count for each automatic measurement
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source; requires R&S®RTO-K31 option
	long-term analysis	history of selected measurements as trace against count index
	histogram	available for each measurement independently
Measurement category	amplitude and time	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, positive overshoot, negative overshoot, area, rise time, fall time, positive width, negative width, period, frequency, positive duty cycle, negative duty cycle, delay, phase, burst width, pulse count, edge count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup time, hold time, setup/hold ratio, pulse train, delay to trigger, DC voltmeter (requires Rohde & Schwarz active probe with R&S®ProbeMeter functionality)
	eye diagram	extinction ratio (%, dB), eye height, eye width, eye top, eye base, Q factor, noise RMS, S/N ratio, duty cycle distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to-peak, 6-sigma, RMS)
	spectrum	channel power, bandwidth, occupied bandwidth, total harmonic distortion, harmonic search
Cursors	setup	up to 2 cursor sets on screen, each set consisting of two horizontal and two vertical cursors
	target	acquired waveforms (input channels), math waveforms, reference waveforms, XY diagrams
	operating mode	vertical measurements, horizontal measurements or both; vertical cursors either set manually or locked to waveform
Histogram	source	acquired waveform (input channels), math waveform, reference waveform
	mode	vertical (for timing statistics), horizontal (for amplitude statistics)
	automatic measurements	waveform count, waveform samples, histogram samples, histogram peak, peak value, upper peak, lower peak, maximum, minimum, median, range, mean, sigma, mean ± 1, 2 and 3 sigma, marker ± probability
Quick measurements	function	fast overview of user-configurable measurements from one channel
	number of measurements	up to 8 simultaneously

	measurements	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, overshoot, area, rise time, fall time, positive width, negative width, period, frequency, duty cycle, burst width, pulse count, edge count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, pulse train

Mask testing

Test definition	number of masks	up to 8 simultaneously
	source	acquired waveforms (input channels), math waveforms, reference waveforms, XY graphs
	fail condition	sample hit or waveform hit
	fail tolerance	minimum number of fail events for test fail in range from 0 to 4 000 000 000
	action on error	acquisition stop, beep, print and save waveform, trigger out
	save/load to file	test and mask settings (.xml format)
Mask definition with segments	number of independent segments	up to 8
	segment definition	array of points and connecting rule (upper, lower, inner) define segment region
	segment input	point and click on touchscreen, editable list
Mask definition with tolerance tube	input signal	acquired waveform
	definition of tolerance tube	horizontal width, vertical width, vertical stretch, vertical position
Result statistics	category	completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail)
Visualization options	waveform style	vectors, dots
	violation highlighting	hits (on/off), highlight persistence (50 ms to 50 s or infinite), waveform color (default: red)
	mask colors	configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red)

Waveform math

General features	number of math waveforms	up to 4
	number of reference waveforms	up to 4
	waveform arithmetic	user-selectable average or envelope of consecutive waveforms
Algebraic expressions	user may define complex mathematical expressions involving waveforms and measurement results	
	math functions	add, subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, $\log_{10}$, $\log_e$, $\log_2$, rescale, sin, cos, tan, arcsin, arccos, arctan, sinh, cosh, tanh, autocorrelation, crosscorrelation
	logical operators	not, and, nand, or, nor, xor, nxor
	relational operators	Boolean result of =, ≠, >, <, ≤, ≥
	frequency domain	spectral magnitude and phase, real and imaginary spectra, group delay
	digital filter	lowpass, highpass
Optimized math	operators	add, subtract, multiply, absolute value, differentiate, $\log_{10}$, $\log_e$, $\log_2$, rescale, FIR, FFT magnitude
Spectrum analysis	FFT magnitude spectrum	
	setup parameters	center frequency, frequency span, frame overlap, frame window (rectangular, Hamming, Hann, Blackman, Gaussian, Flattop, Kaiser Bessel), user-selectable spectrum averaging and envelope

Search and mark function

General description	scans acquired waveforms for occurrence of a user-defined set of events and highlights each occurrence	
Basic setup	source	acquired waveforms (input channels), math waveforms, reference waveforms
	search panels	up to 4, where each panel may manage multiple event searches
	search mode	manually triggered or continuous
	search conditions	
	supported events	edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, state, pattern
	event configuration	identical to corresponding trigger event
	event selection	single or multiple events on same source
Search scope	mode	current waveform, gated time interval
Result visualization	table	
	sort mode	horizontal position or vertical value
	max. result count	specifies max. table size
	zoom window	centered on highlighted event

Display characteristics

Diagram types	Yt, XY, spectrum, long-term measurement
Display interface configuration	display area can be split up into separate diagram areas by dragging and dropping signal icons; each diagram area can hold any number of signals; diagram areas may be stacked on top of each other and later accessed via the dynamic tab menu
Signal bar	accommodates timebase settings, trigger settings and signal icons; signal bar may be docked to left or right side of display area or hidden
Signal icon	each active waveform is represented by a separate signal icon on the signal bar; the signal icon displays the individual vertical and acquisition settings; a waveform can be minimized to its signal icon so that it appears as a realtime preview in miniature form; dialog boxes and measurement results may also be minimized to a signal icon
Axis label	X-axis ticks and Y-axis ticks labeled with tick value and physical unit
Diagram label	diagrams may be individually labeled with a descriptive user-defined name
Diagram layout	grid, crosshair, axis labels and diagram label may be switched on and off separately
Persistence	50 ms to 50 s, or infinite
Zoom	user-defined zoom window provides vertical and horizontal zoom; each diagram area supports multiple zoom windows; touchscreen interface simplifies resize and drag operations on zoom window
Signal colors	predefined or user-defined color tables for persistence display

Input and output

Front		
Channel inputs		BNC-compatible, for details see “Vertical system”
	probe interface	auto-detection of passive probes, Rohde & Schwarz active probe interface
External trigger input		BNC-compatible, for details see “Trigger system”
Probe compensation output	signal shape	rectangle, V_{low} = 0 V, V_{high} = 1 V amplitude 1 V (V_{pp}) ± 5 %
	frequency	1 kHz ± 1 %
	impedance	50 Ω (nom.)
Ground jack		connected to ground
USB interface		2 ports, type A plug, version 2.0

Rear		
Trigger out		SMA, for details see “Trigger system”
USB interface		2 ports, type A plug, version 3.0
LAN interface		RJ-45 connector, supports 10/100/1000BaseT
External monitor interface		DVI-D connector, output of scope display or extended desktop display
Reference input/output	connector	BNC female, software switch for selection of input/output
	input	
	impedance	50 Ω (nom.)
	input frequency	10 MHz
	required level	≥ 0 dBm into 50 Ω
	output	
	impedance	50 Ω (nom.)
	output frequency	10 MHz (nom.)
	level	> 7 dBm
GPIB interface		see R&S®RTE-B10 option
Security slot		for standard Kensington style lock

General data

Display	type	10.4" LC TFT color display with touchscreen
	resolution	1024 × 768 pixel (XGA)

Temperature		
Temperature loading	operating temperature range	0 °C to +45 °C
	storage temperature range	–40 °C to +70 °C
Climatic loading		+25° C/+40 °C at 85 % rel. humidity cyclic, in line with IEC 60068-2-30

Altitude		
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level

Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, 1.8 g at 55 Hz, 0.5 g from 55 Hz to 150 Hz, in line with EN 60068-2-6
	random	10 Hz to 300 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64
Shock		40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I

EMC		
RF emission	in line with EN 55011 class A, operation in residential, commercial and business areas or in small-size companies is not covered; therefore the instrument may not be operated in residential, commercial and business areas or in small-size companies unless additional measures are taken to ensure that EN 55011 class B is complied with	in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emission requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments
Immunity		in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environment [2]

Certifications		VDE-GS, $_{C}CSA_{US}$

Calibration interval		1 year

Power supply		
AC supply		100 V to 240 V at 50 Hz to 60 Hz and 400 Hz, max. 3.3 A to 1.5 A, in line with MIL-PRF 28800F section 3.5
Power consumption		max. 300 W
Safety		in line with IEC 61010-1, EN 61010-1, CAN/CSA-C22.2 No. 61010-1-04, UL 61010-1

[2] Test criterion is displayed noise level within ±1.5 div for input sensitivity of 5 mV/div.

Mechanical data		
Dimensions	W × H × D	427 mm × 249 mm × 204 mm (16.81 in × 9.80 in × 8.03 in)
Weight	without options, nominal	8.8 kg (19.64 lb)

Options

R&S®RTE-B1

Mixed signal option, additional 16 logic channels

Vertical system

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the logic probes to the channels (D0 to D7 or D8 to D15) is displayed on the probe
Input impedance		100 kΩ ± 2 % || ~4 pF (meas.) at probe tips
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: normal	400 MHz (meas.)
Maximum input voltage		±40 V (V_p)
Minimum input voltage swing		500 mV (V_{pp}) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V, TTL, ECL, PECL, LVPECL
Threshold accuracy		±(100 mV + 3 % of threshold setting)
Comparator hysteresis		normal, robust, maximum

Horizontal system

Channel deskew	range for each channel	±200 ns
Channel-to-channel skew		< 500 ps (meas.)

Acquisition system

Sampling rate	max.	5 Gsample/s on each channel
Realtime waveform acquisition rate	max.	> 200 000 waveforms/s
Memory depth		100 Msample for every channel
Decimation		pulses lost due to decimation are displayed

Trigger system

Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

Trigger modes		
Edge	triggers on specified slope (positive, negative or either) in the source signal	
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
Width	triggers on positive or negative pulse of specified width in the source signal; width can be shorter, longer, equal, inside or outside the interval	
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
	pulse width	200 ps to 10 s
Timeout	triggers when the source signal stays high, low or unchanged for a specified period of time	
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
	timeout	200 ps to 10 s
Data2clock	triggers on setup time and hold time violations between a clock signal and a data signal; monitored time interval with a max. width of 200 ns and a position of max. ±1 µs relative to the clock edge	
	data signal	any subset of channels from D0 to D15 or any user-defined bus signal
	clock signal	any channel from D0 to D15

Pattern	triggers when the source goes true or stays true for a period of time shorter, longer, equal, inside or outside a specified range	
	sources	any logical combination of D0 to D15 or any user-defined bus signal
	pulse width	200 ps to 10 s
State	triggers on the slope (positive, negative or either) of the clock signal when data signal matches a user-defined logical state	
	data signal	any logical combination of D0 to D15 or any user-defined bus signal
	clock signal	any channel from D0 to D15
Serial pattern	triggers on a serial data pattern of up to 32 bit; pattern bits may be high (H), low (L) or don't care (X); clock edge slope may be positive, negative or either	
	data signal	any channel from D0 to D15 or any logical combination of D0 to D15
	clock signal	any channel from D0 to D15 or any analog channel
	max. data rate	1.00 Gbps
	optional	I^2C, SPI, UART/RS-232, LIN, CAN, FlexRay™ and I^2S with dedicated software options
	sources	any channel from D0 to D15

Waveform measurements

General features		measurement panels, gate, statistics, long-term analysis and limit check; see features of the base unit
Measurement sources		all channels from D0 to D15 or any logical combination of D0 to D15
Automatic measurements		positive pulse width, negative pulse width, period, frequency, burst width, delay, phase, positive duty cycle, negative duty cycle, positive pulse count, negative pulse count, rising edge count, falling edge count
Additional cursor function		display of decoded bus value at the cursor position

Waveform math

Function		any logical combination of D0 to D15

Search and mark functions

The search function will be available in a future software release.

Display characteristics

Display of logical channels		selectable size and position on screen, diagram configuration by dragging and dropping signal icons
Bus decode	number of bus signals	4
	bus types	unclocked and clocked
	display types	decoded bus, logical signal, bus + logical signal, amplitude signal, amplitude + logical signal, tabulated list (decoded time interval selected with cursors)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, unsigned integer, signed integer, fractional, binary
	data format of amplitude signal	unsigned integer, signed integer, fractional, binary offset
Channel activity display		independent of the scope acquisition, the state (stays low, stays high or toggles) of the channels from D0 to D15 is displayed in the signal icon

R&S®RTE-B10

Additional GPIB interface		
Function		interface in line with IEC 625-2 (IEEE 488.2)
Command set		SCPI 1999.0
Connector		24-pin Amphenol female
Interface functions		SH1, AH1, T6, L4, SR1, RL1, PP1, DC1, DT1, C0

R&S®RTE-B18

Additional removable solid state disk		
Disk type		solid state disk
Disk size		≥ 240 Gbyte (nom.)
Firmware		installed upon delivery

R&S®RTE-B19

Additional removable hard disk		
Disk type		hard disk
Disk size		≥ 500 Gbyte (nom.)
Firmware		installed upon delivery

R&S®RTE-K1

I^2C triggering and decoding		
Protocol configuration	bit rate	up to 3.4 Mbps (auto-detected)
	auto threshold setup	assisted threshold configuration for I^2C triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, restart, missing ACK, address, data, address + data
	address setup	7 bit or 10 bit address (value in hex, decimal, octal or binary); ACK, NACK or either; read, write or either; R/W bit included in address value or apart; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition =, ≠; ≥, ≤, in range, out of range; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, start/restart, address, R/W bit, data, ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII; symbolic names for user-defined subset of addresses

SPI triggering and decoding		
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	up to 50 Mbps (auto-detected)
	bit order	LSB first, MSB first
	word size	4 bit to 32 bit
	frame condition	SS, timeout
	polarity (MOSI, MISO, SS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
	auto threshold setup	assisted threshold configuration for SPI triggering and decoding
Trigger	source (MOSI, MISO, SS, CLK)	any input channel or logical channel
	trigger event setup	start of frame, MOSI, MISO, MOSI + MISO
	data setup	data pattern up to 256 bit (hex or binary); condition =, ≠; offset within frame in range from 0 bit to 32767 bit
Decode	source (MOSI, MISO, SS, CLK)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII

R&S®RTE-K2

UART/RS-232/RS-422/RS-485 triggering and decoding		
Protocol configuration	bit rate	300 bps to 20 Mbps
	signal polarity	idle low, idle high
	number of bits	5 bit to 8 bit
	bit order	LSB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5 or 2 bit periods
	end of packet	word, timeout, none
	auto threshold setup	assisted threshold configuration for UART triggering and decoding
Trigger	source (TX and RX)	any input channel or logical channel
	trigger event setup	start bit, packet start, data, parity error, break condition
	data setup	data pattern up to 256 bit (hex, decimal, octal, binary or ASCII); condition =, ≠; offset within packet in range 0 bit to 32767 bit
Decode	source (TX and RX)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet, data payload, start error, parity error, stop error
	data format	hex, decimal, octal, binary, ASCII

R&S®RTE-K3

CAN triggering and decoding		
Protocol configuration	signal type	CAN_H, CAN_L
	bit rate	100 bps to 1 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID, load DBC file content
	auto threshold setup	assisted threshold configuration for CAN triggering and decoding
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); big-endian or little-endian; condition =, ≠; ≥, ≤, in range, out of range
	symbolic setup	message name, signal name; numeric signal condition =, ≠, ≥, ≤, in range, out of range; enumerated signal condition =, ≠, ≥, ≤
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error
	data format	hex, decimal, octal, binary, ASCII, symbolic
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) or only symbolic
	event settings	same as trigger event settings

LIN triggering and decoding		
Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic is supported
	bit rate	standard bit rate (1.2/2.4/4.8/9.6/10.417/ 19.2 kbps) or user-defined bit rate in range from 1 kbps to 20 kbps
	device list	associate frame identifier with symbolic ID, data length and protocol version
	auto threshold setup	assisted threshold configuration for LIN triggering and decoding
Trigger	source	any input channel
	trigger event setup	start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum error, parity error and sync field error)
	identifier setup	range from 0d to 63d; select condition =, ≠, ≥, ≤, in range, out of range for trigger “identifier”; select single identifier and condition = for trigger “identifier + data”
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition =, ≠, ≥, ≤, in range, out of range
Decode	source (TX and RX)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, frame identifier, data payload, checksum, error condition
	data format	hex, decimal, octal, binary, ASCII

R&S®RTE-K4

FlexRay™ triggering and decoding		
Protocol configuration	signal type	single-ended, differential, logic
	channel type	channel A, channel B
	bit rate	standard bit rates (2.5/5.0/10.0 Mbps)
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration for FlexRay™ triggering and decoding
	source	any input channel or logical channel
Trigger	trigger event setup	start of frame, header + data, symbol, wakeup, error condition (any combination of FSS error, BSS error, FES error, header CRC error and frame CRC error)
	header setup	indicator bits, identifier, payload length, cycle count
	indicator bits setup	payload preamble bit, null frame bit, sync frame bit and startup frame bit separately configurable (1, 0 or don't care)
	identifier setup	condition =, ≠, ≥, ≤, in range, out of range
	payload length setup	condition =, ≠, ≥, ≤, in range, out of range
	cycle count	condition =, ≠, ≥, ≤, in range, out of range; step parameter for selection of non-contiguous values within provided range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition =, ≠, ≥, ≤, in range, out of range; offset within frame in range from 0 byte to 253 byte
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, frame header, identifier, payload length, header CRC, cycle count, data payload, frame CRC, error condition
	data format	hex, decimal, octal, binary, ASCII
Search	search event setup	combination of start of frame, header + data, symbol, wakeup, error condition (any combination of FSS error, BSS error, FES error, header CRC error and frame CRC error)
	event settings	same as trigger event settings

R&S®RTE-K5

I²S triggering and decoding		
Protocol configuration	signal type	I²S standard, left justified, right justified, TDM
	auto threshold setup	assisted threshold configuration for I²S triggering and decoding
Trigger	source	any input channel or logical channel
	trigger event setup	data, window, frame condition, word select, error condition
	data setup	data pattern of an audio channel up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition =, ≠; ≥, ≤, <, >, in range, out of range
	window setup	word count of data pattern of an audio channel up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition =, ≠; ≥, ≤, <, >, in range, out of range
	frame condition setup	combination of audio channels in a frame, up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition =, ≠; ≥, ≤, <, >, in range, out of range
	word select setup	rising or falling edge of word select input channel
	error condition setup	source of word select
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus and logical signal, tabulated list
	color coding	audio frame, frame error, incomplete frame
	data format	hex, unsigned decimal, signed decimal (two's complement), octal, binary, ASCII
Protocol measurements	audio display	display of audio waveform for specified audio channels
	long-term display	history of selected audio data as trace against measurements, waveforms and time index

R&S®RTE-K6

MIL-STD-1553 triggering and decoding		
Protocol configuration	signal type	single-ended
	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (2 µs to 262 µs) or off; max. response (2 µs to 262 µs) or off
Trigger	trigger event setup	sync, word, data word, command/status word, command word, status word, error condition
	sync and word setup	all words, command/status word, data word
	data word setup	RTA (condition =, ≠, ≥, ≤, in range, out of range); data pattern (condition =, ≠, ≥, ≤, in range, out of range); payload data index (=, <, >, ≥, ≤, range); max length of data pattern is 4 byte
	command/status word setup	RTA (condition =, ≠, ≥, ≤, in range, out of range); 11 bit pattern (condition =, ≠, ≥, ≤, in range, out of range)
	command word setup	RTA (condition =, ≠, ≥, ≤, in range, out of range); subaddress/mode (condition =, ≠, ≥, ≤, in range, out of range); data word count/mode count (condition =, ≠, ≥, ≤, in range, out of range); direction (T/R)
	status word	RTA (condition =, ≠, ≥, ≤, in range, out of range); status flags (message error, instrumentation, service request, broadcast command, busy, subsystem flag, dynamic bus control, terminal flag)
	error condition	any combination of sync error, Manchester error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), sync, RTA, status bit field, parity, data field, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	sync, word, data word, command/status word, command word, status word, error condition
	event settings	same as trigger event settings

R&S®RTE-K7

ARINC 429 triggering and decoding		
Protocol configuration	signal type	single-ended
	bit rate	high (100 kbit/s)
		low (12 kbit/s to 14.5 kbit/s)
	polarity	A leg, B leg
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (0 bit to 100 bits) or off; max. gap (0 bit to 1000 bits) or off
Trigger	trigger event setup	word start, word stop, label + data, error condition
	label + data setup	label (condition =, ≠, ≥, ≤, in range, out of range); data (condition =, ≠, ≥, ≤, in range, out of range); SDI/SSM
	error condition	any combination of coding error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), label, SDI, data, SSM, parity, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	word start, word stop, label + data, error condition
	event settings	same as trigger event settings

R&S®RTE-K8

Ethernet decoding		
Protocol configuration	signal type	one channel, differential
	bit rate	selectable/adjustable
	auto threshold setup	assisted threshold configuration
	source (SDATA)	analog and math channels
	variants	10BASE-T, 100BASE-TX
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, details
	color coding	preamble, frame, destination address, source address, data
	data format	hex
Search	search event setup	frame, error
	frame	48 bit destination address, 48 bit source address, 16 bit length/type, 32 bit frame check; conditions =, ≠, <, ≤, >, ≥, in range, out of range
	error	preamble, length error

R&S®RTE-K9

CAN FD triggering and decoding		
Protocol configuration	signal type	CAN_H, CAN_L
	bit rate	
	arbitration rate	10 kbps to 1 Mbps
	data rate	10 kbps to 15 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID, load DBC file content
	auto threshold setup	assisted threshold configuration
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range
	FD bits	FDF and ESI (0, 1, X), BRS (0, 1)
	data setup	data pattern up to 8 byte in the complete data range (hex, decimal, octal or binary); condition =, ≠; ≥, ≤, in range, out of range
	symbolic setup	message name, signal name; numeric signal condition =, ≠, ≥, ≤, in range, out of range; enumerated signal condition =, ≠, ≥, ≤
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, FD bits, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error
	data format	hex, decimal, octal, binary, ASCII, symbolic
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) or only symbolic
	event settings	same as trigger event settings

R&S®RTE-K17

High definition mode		
General description	The R&S®RTE-K17 high definition mode increases the numeric resolution of the waveform signal by using digital filtering, leading to a reduced noise. Because of the R&S®RTE digital trigger concept the signals with increased numeric resolution are used as input for triggering.	
Numeric resolution	bandwidth	bit resolution
	10 kHz to 30 MHz	16 bit
	50 MHz	14 bit
	100 MHz	13 bit
	200 MHz	12 bit
	300 MHz	11 bit
	500 MHz	10 bit
Realtime sampling rate		max. 2.5 Gsample/s on each channel
Input sensitivity		Input sensitivity range is extended down to 500 µV/div; 500 µV/div is a magnification of the 1 mV/div setting.

R&S®RTE-K31

Power analysis		
General description	The R&S®RTE-K31 power analysis option extends the R&S®RTE firmware with measurement functionality focused on switched mode power supplies (SMPS) and DC/DC converters.	
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current
	harmonics	measures up to the 40th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO 160, MIL-STD-1399, max. limit checks
	inrush current	measures peak inrush current; multiple measurement zones configurable with analysis of the post-inrush behavior
Switching/control loop	slew rate	The slope of current or voltage is measured at start and end of the switching cycle.
	modulation	measures modulation of switching frequency and duty cycle under steady state and start-up conditions
	dynamic on-resistance	measures resistance of the switching transistor(s) in active state
Power path	efficiency (only for 4 channel devices)	measures input and output power to calculate the efficiency of an SMPS
	loss	measures switching loss and conduction loss of a power device
	safe operating area (SOA)	checks violation of voltage and current limits in which a power device can operate without damage; current versus voltage view (linear or log); violation mask is user-defined and editable in linear and log-log views
	turn on/off	measures relationship between AC and DC current, when turning the SMPS off and on
Output	ripple	measures AC components of output voltage and current, AC RMS, frequency, duty cycles, min./max./peak-to-peak amplitude
	spectrum	FFT analysis of output, measurement of frequency peaks
	transient response	This measurement captures the device behavior between the event of load changes and stabilization. includes peak (voltage, time), settling time, rise time, overshoot and delay
Deskew	automated	By using the R&S®RT-ZF20 probe deskew and calibration test fixture and Rohde & Schwarz voltage and current probes, the skew between the voltage and current signal is compensated automatically.
Reporting	easy reporting: Click to save a measurement. Report generation using user-selected test results from historical and currently-active tests. Put repeated and/or different measurements in one report.	

R&S®RTE-K55

MDIO triggering and decoding		
Protocol configuration	bit rate	up to 5 Mbps (auto-detected)
	auto threshold setup	assisted threshold configuration for MDIO triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, ST, OP, PHY address, register address, data
	ST setup	01 (clause 22), 00 clause 45, any
	OP setup	address, write, post read, read, any
	PHY address setup	5 bit address (hex, decimal, octal or binary); equal
	PHY register (clause 22)/device type (clause 45) setup	5 bit value (hex, decimal, octal or binary); equal
	data (clause 22)/data/address (clause 45)	16 bit value (hex, decimal, octal or binary); equal
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, PHY address, PHY register, address, data, turnaround
	PHYAD/PRTAD	symbolic names for user defined addresses
	address/data field format	hex, decimal, octal, binary, ASCII
Search	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	search event setup	start, stop, ST, OP, PHY address, register address, data
	event settings	same as trigger event settings

Ordering information

Designation	Type	Order No.
Base unit (including standard accessories: R&S®RTE-ZP10 500 MHz passive probe per channel, accessories bag, quick start guide, CD with manual, power cord)		
Digital Oscilloscope		
200 MHz, 5 Gsample/s, 10/20 Msample, 2 channels	R&S®RTE1022	1317.2500.22
200 MHz, 5 Gsample/s, 10/40 Msample, 4 channels	R&S®RTE1024	1317.2500.24
350 MHz, 5 Gsample/s, 10/20 Msample, 2 channels	R&S®RTE1032	1317.2500.32
350 MHz, 5 Gsample/s, 10/40 Msample, 4 channels	R&S®RTE1034	1317.2500.34
500 MHz, 5 Gsample/s, 10/20 Msample, 2 channels	R&S®RTE1052	1317.2500.52
500 MHz, 5 Gsample/s, 10/40 Msample, 4 channels	R&S®RTE1054	1317.2500.54
1 GHz, 5 Gsample/s, 10/20 Msample, 2 channels	R&S®RTE1102	1317.2500.02
1 GHz, 5 Gsample/s, 10/40 Msample, 4 channels	R&S®RTE1104	1317.2500.04
Hardware options (plug-in)		
Mixed Signal Option, 400 MHz, 5 Gsample/s, 16 channels, 100 Msample/channel	R&S®RTE-B1	1317.4961.02
GPIB Interface	R&S®RTE-B10	1317.4978.02
Replacement SSD Hard Disk, incl. firmware	R&S®RTE-B18	1317.7002.02
Replacement Hard Disk, incl. firmware	R&S®RTE-B19	1317.7019.02
Sample memory upgrade		
Memory Upgrade, 20 Msample per channel	R&S®RTE-B101	1317.7331.02
Memory Upgrade, 50 Msample per channel	R&S®RTE-B102	1317.7348.02
Bandwidth upgrade		
Upgrade of R&S®RTE1022/4 oscilloscopes to 350 MHz bandwidth, incl. calibration	R&S®RTE-B200	1317.7254.02
Upgrade of R&S®RTE1022/4 oscilloscopes to 500 MHz bandwidth, incl. calibration	R&S®RTE-B201	1317.7260.02
Upgrade of R&S®RTE1022/4 oscilloscopes to 1 GHz bandwidth, incl. calibration	R&S®RTE-B202	1317.7277.02
Upgrade of R&S®RTE1032/4 oscilloscopes to 500 MHz bandwidth, incl. calibration	R&S®RTE-B204	1317.7283.02
Upgrade of R&S®RTE1032/4 oscilloscopes to 1 GHz bandwidth, incl. calibration	R&S®RTE-B205	1317.7290.02
Upgrade of R&S®RTE1052/4 oscilloscopes to 1 GHz bandwidth, incl. calibration	R&S®RTE-B207	1317.7302.02
Software options		
Serial triggering and decoding		
I^2C/SPI Serial Triggering and Decoding	R&S®RTE-K1	1317.7125.02
UART/RS-232/RS-422/RS-485 Serial Triggering and Decoding	R&S®RTE-K2	1317.7131.02
CAN/LIN Serial Triggering and Decoding	R&S®RTE-K3	1317.7148.02
FlexRay™ Serial Triggering and Decoding	R&S®RTE-K4	1317.7154.02
I^2S Serial Triggering and Decoding	R&S®RTE-K5	1317.7160.02
MIL-STD-1553 Serial Triggering and Decoding	R&S®RTE-K6	1325.9781.02
ARINC 429 Serial Triggering and Decoding	R&S®RTE-K7	1325.9798.02
Ethernet Serial Decoding	R&S®RTE-K8	1317.7402.02
CAN FD Serial Triggering and Decoding	R&S®RTE-K9	1325.9898.02
MDIO Serial Triggering and Decoding	R&S®RTE-K55	1326.0720.02
Analysis		
High Definition Mode	R&S®RTE-K17	1326.0542.02
Power Analysis	R&S®RTE-K31	1317.7177.02

Designation	Type	Order No.
Probes		
500 MHz, passive, 10:1, 1 MΩ || 9.5 pF, max. 400 V	R&S®RT-ZP10	1409.7550.00
400 MHz, passive, high-voltage, 100:1, 50 MΩ || 7.5 pF, 1 kV (RMS)	R&S®RT-ZH10	1409.7720.02
400 MHz, passive, high-voltage, 1000:1, 50 MΩ || 7.5 pF, 1 kV (RMS)	R&S®RT-ZH11	1409.7737.02
1.0 GHz, active, 1 MΩ || 0.8 pF	R&S®RT-ZS10E	1418.7007.02
1.0 GHz, active, 1 MΩ || 0.8 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS10	1410.4080.02
1.5 GHz, active, 1 MΩ || 0.8 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS20	1410.3502.02
100 MHz, high-voltage, active, differential, 8 MΩ || 3.5 pF, 1 kV (RMS) (CAT III)	R&S®RT-ZD01	1422.0703.02
1.0 GHz, active, differential, 1 MΩ || 0.6 pF, R&S®ProbeMeter, micro button	R&S®RT-ZD10	1410.4715.02
1.5 GHz, active, differential, 1 MΩ || 0.6 pF, R&S®ProbeMeter, micro button	R&S®RT-ZD20	1410.4409.02
10 MHz, current, AC/DC, 0.01 V/A, 150 A (RMS)	R&S®RT-ZC10	1409.7750.02
100 MHz, current, AC/DC, 0.1 V/A, 30 A (RMS)	R&S®RT-ZC20	1409.7766.02
Probe accessories		
Accessory Set for R&S®RTE-ZP10 passive probe (2.5 mm probe tip)	R&S®RT-ZA1	1409.7566.00
Spare Accessory Set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA2	1416.0405.02
Pin Set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA3	1416.0411.02
Mini Clips	R&S®RT-ZA4	1416.0428.02
Micro Clips	R&S®RT-ZA5	1416.0434.02
Lead Set	R&S®RT-ZA6	1416.0440.02
Pin Set for R&S®RT-ZD10/20/30	R&S®RT-ZA7	1417.0609.02
Pin Set for R&S®RT-ZD40	R&S®RT-ZA8	1417.0867.02
Adapter SMA(f) to BNC(m)	R&S®RT-ZA10	1416.0457.02
Probe Power Supply	R&S®RT-ZA13	1409.7789.02
External Attenuator, incl. adjustment tool	R&S®RT-ZA15	1410.4744.02
Accessories		
Front Cover, for R&S®RTO/RTE digital oscilloscopes	R&S®RTO-Z1	1317.6970.02
Soft Case, for R&S®RTO/RTE digital oscilloscopes and accessories	R&S®RTO-Z3	1304.9118.02
Transit Case, for R&S®RTO/RTE digital oscilloscopes and accessories	R&S®RTO-Z4	1317.7025.02
Probe Pouch, for R&S®RTO/RTE digital oscilloscopes	R&S®RTO-Z5	1317.7031.02
Probe Deskew and Calibration Test Fixture	R&S®RT-ZF20	1800.0004.02
19" Rackmount Kit, for R&S®RTO/RTE digital oscilloscopes with 6 HU	R&S®ZZA-RTO	1304.8286.02

Service options		
Extended Warranty, one year	R&S®WE1	Please contact your local Rohde & Schwarz sales office.
Extended Warranty, two years	R&S®WE2	
Extended Warranty, three years	R&S®WE3	
Extended Warranty, four years	R&S®WE4	
Extended Warranty with Calibration Coverage, one year	R&S®CW1	
Extended Warranty with Calibration Coverage, two years	R&S®CW2	
Extended Warranty with Calibration Coverage, three years	R&S®CW3	
Extended Warranty with Calibration Coverage, four years	R&S®CW4	

Extended warranty with a term of one to four years (WE1 to WE4)
Repairs carried out during the contract term are free of charge [3]. Necessary calibration and adjustments carried out during repairs are also covered. Simply contact the forwarding agent we name; your product will be picked up free of charge and returned to you in top condition a couple of days later.

Extended warranty with calibration (CW1 to CW4)
Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs [3] and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

[3] Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

Service that adds value

- Worldwide
- Local and personalized
- Customized and flexible
- Uncompromising quality
- Long-term dependability

About Rohde&Schwarz

The Rohde&Schwarz electronics group is a leading supplier of solutions in the fields of test and measurement, broadcasting, secure communications, and radiomonitoring and radiolocation. Founded more than 80 years ago, this independent global company has an extensive sales network and is present in more than 70 countries.
The company is headquartered in Munich, Germany.

Sustainable product design

- Environmental compatibility and eco-footprint
- Energy efficiency and low emissions
- Longevity and optimized total cost of ownership

Certified Quality Management
ISO 9001

Certified Environmental Management
ISO 14001

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